

# FDZ197PZ

## P-Channel 1.5 V Specified PowerTrench® Thin WL-CSP MOSFET -20 V, -3.8 A, 64 mΩ

### Features

- Max  $r_{DS(on)}$  = 64 mΩ at  $V_{GS} = -4.5$  V,  $I_D = -2.0$  A
- Max  $r_{DS(on)}$  = 71 mΩ at  $V_{GS} = -2.5$  V,  $I_D = -2.0$  A
- Max  $r_{DS(on)}$  = 79 mΩ at  $V_{GS} = -1.8$  V,  $I_D = -1.0$  A
- Max  $r_{DS(on)}$  = 95 mΩ at  $V_{GS} = -1.5$  V,  $I_D = -1.0$  A
- Occupies only 1.5 mm<sup>2</sup> of PCB area. Less than 50% of the area of 2 x 2 BGA
- Ultra-thin package: less than 0.65 mm height when mounted to PCB
- HBM ESD protection level > 4400V (Note3)
- RoHS Compliant

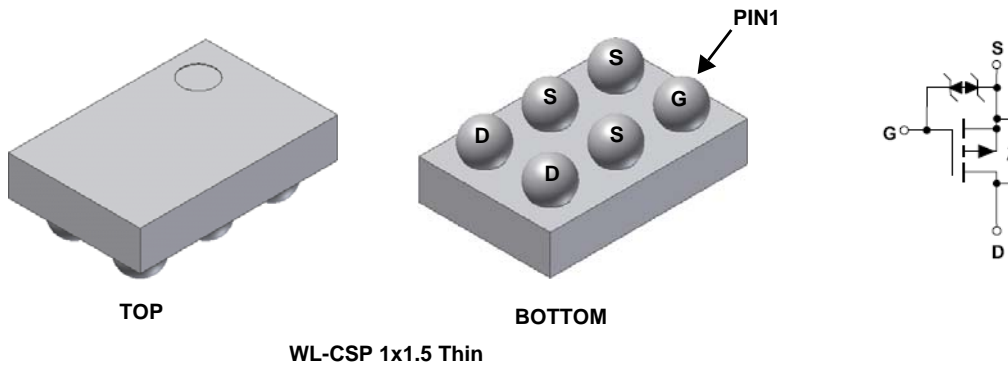


### General Description

Designed on Fairchild's advanced 1.5 V PowerTrench® process with state of the art "fine pitch" WLCSP packaging process, the FDZ197PZ minimizes both PCB space and  $r_{DS(on)}$ . This advanced WLCSP MOSFET embodies a breakthrough in packaging technology which enables the device to combine excellent thermal transfer characteristics, ultra-low profile packaging, low gate charge, and low  $r_{DS(on)}$ .

### Applications

- Battery management
- Load switch
- Battery protection



WL-CSP 1x1.5 Thin

### MOSFET Maximum Ratings $T_A = 25^\circ\text{C}$ unless otherwise noted

| Symbol         | Parameter  | Rated                              | Units |
|----------------|--|------------------------------------|-------|
| $V_{DS}$       | Drain to Source Voltage                          | -20                                | V     |
| $V_{GS}$       | Gate to Source Voltage                           | ±8                                 | V     |
| $I_D$          | -Continuous                                      | $T_A = 25^\circ\text{C}$ (Note 1a) | -3.8  |
|                | -Pulsed  |                                    | -15   |
| $P_D$          | Power Dissipation                                | $T_A = 25^\circ\text{C}$ (Note 1a) | 1.9   |
|                | Power Dissipation                                | $T_A = 25^\circ\text{C}$ (Note 1b) | 0.9   |
| $T_J, T_{STG}$ | Operating and Storage Junction Temperature Range | -55 to +150                        | °C    |

### Thermal Characteristics

|                 |   |           |     |      |
|-----------------|---|-----------|-----|------|
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient | (Note 1a) | 65  | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient | (Note 1b) | 133 |      |

### Package Marking and Ordering Information

| Device Marking | Device   | Package           | Reel Size | Tape Width | Quantity   |
|----------------|----------|-------------------|-----------|------------|------------|
| 7              | FDZ197PZ | WL-CSP 1x1.5 Thin | 7"        | 8 mm       | 5000 units |

**Electrical Characteristics**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|--------|-----------|-----------------|-----|-----|-----|-------|
|--------|-----------|-----------------|-----|-----|-----|-------|

**Off Characteristics**

|                                      |   |  |     |     |          |                      |
|--------------------------------------|---|--|-----|-----|----------|----------------------|
| $BV_{DSS}$                           | Drain to Source Breakdown Voltage         | $I_D = -250\text{ }\mu\text{A}$ , $V_{GS} = 0\text{ V}$                    | -20 |     |          | V                    |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature Coefficient | $I_D = -250\text{ }\mu\text{A}$ , referenced to $25\text{ }^\circ\text{C}$ |     | -10 |          | mV/ $^\circ\text{C}$ |
| $I_{DSS}$                            | Zero Gate Voltage Drain Current           | $V_{DS} = -16\text{ V}$ , $V_{GS} = 0\text{ V}$                            |     |     | -1       | $\mu\text{A}$        |
| $I_{GSS}$                            | Gate to Source Leakage Current            | $V_{GS} = \pm 8\text{ V}$ , $V_{DS} = 0\text{ V}$                          |     |     | $\pm 10$ | $\mu\text{A}$        |

**On Characteristics**

|  |  |  |      |      |      |                      |
|--|--|--|------|------|------|----------------------|
| $V_{GS(th)}$                           | Gate to Source Threshold Voltage                         | $V_{GS} = V_{DS}$ , $I_D = -250\text{ }\mu\text{A}$                                  | -0.4 | -0.5 | -1.0 | V                    |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate to Source Threshold Voltage Temperature Coefficient | $I_D = -250\text{ }\mu\text{A}$ , referenced to $25\text{ }^\circ\text{C}$           |      | 2.7  |      | mV/ $^\circ\text{C}$ |
| $r_{DS(on)}$                           | Static Drain to Source On Resistance                     | $V_{GS} = -4.5\text{ V}$ , $I_D = -2.0\text{ A}$                                     |      | 46   | 64   | m $\Omega$           |
|  |  | $V_{GS} = -2.5\text{ V}$ , $I_D = -2.0\text{ A}$                                     |      | 53   | 71   |                      |
|  |  | $V_{GS} = -1.8\text{ V}$ , $I_D = -1.0\text{ A}$                                     |      | 59   | 79   |                      |
|  |  | $V_{GS} = -1.5\text{ V}$ , $I_D = -1.0\text{ A}$                                     |      | 68   | 95   |                      |
|  |  | $V_{GS} = -4.5\text{ V}$ , $I_D = -2.0\text{ A}$ , $T_J = 125\text{ }^\circ\text{C}$ |      | 54   | 84   |                      |
| $g_{FS}$                               | Forward Transconductance                                 | $V_{DD} = -5\text{ V}$ , $I_D = -3.8\text{ A}$                                       |      | 21   |      | S                    |

**Dynamic Characteristics**

|           |                              |   |  |      |      |    |
|-----------|------------------------------|---|--|------|------|----|
| $C_{iss}$ | Input Capacitance            | $V_{DS} = -10\text{ V}$ , $V_{GS} = 0\text{ V}$ ,<br>$f = 1\text{ MHz}$ |  | 1180 | 1570 | pF |
| $C_{oss}$ | Output Capacitance           |   |  | 190  | 255  | pF |
| $C_{rss}$ | Reverse Transfer Capacitance |   |  | 160  | 225  | pF |

**Switching Characteristics**

|              |                               |   |   |     |     |    |
|--------------|-------------------------------|---|---|-----|-----|----|
| $t_{d(on)}$  | Turn-On Delay Time            | $V_{DD} = -10\text{ V}$ , $I_D = -3.8\text{ A}$ ,<br>$V_{GS} = -4.5\text{ V}$ , $R_{GEN} = 6\text{ }\Omega$ |   | 5.8 | 12  | ns |
| $t_r$        | Rise Time                     |   |   | 5.9 | 12  | ns |
| $t_{d(off)}$ | Turn-Off Delay Time           |   |   | 311 | 498 | ns |
| $t_f$        | Fall Time                     |   |   | 280 | 448 | ns |
| $Q_g$        | Total Gate Charge             |   | $V_{GS} = 0\text{ V to } -4.5\text{ V}$ |     | 18  | 25 |
| $Q_{gs}$     | Gate to Source Charge         | $V_{DD} = -10\text{ V}$ ,<br>$I_D = -3.8\text{ A}$  |   | 1.5 |     | nC |
| $Q_{gd}$     | Gate to Drain "Miller" Charge |   |   | 4.7 |     | nC |

**Drain-Source Diode Characteristics**

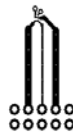
|          |                                       |  |  |      |      |    |
|----------|---------------------------------------|--|--|------|------|----|
| $V_{SD}$ | Source to Drain Diode Forward Voltage | $V_{GS} = 0\text{ V}$ , $I_S = -1.1\text{ A}$ (Note 2)     |  | -0.6 | -1.2 | V  |
| $t_{rr}$ | Reverse Recovery Time                 | $I_F = -3.8\text{ A}$ , $di/dt = 100\text{ A}/\mu\text{s}$ |  | 194  | 310  | ns |
| $Q_{rr}$ | Reverse Recovery Charge               |  |  | 344  | 550  | nC |

**Notes:**

1.  $R_{\theta JA}$  is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a. 65  $^\circ\text{C}/\text{W}$  when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.

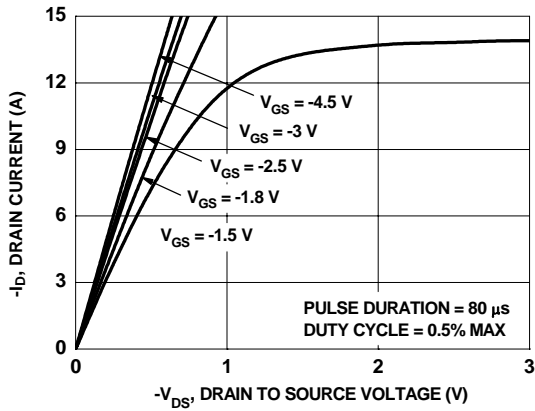


b. 133  $^\circ\text{C}/\text{W}$  when mounted on a minimum pad of 2 oz copper.

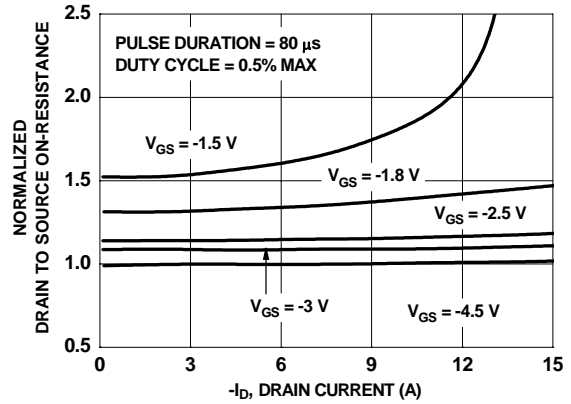
2. Pulse Test: Pulse Width < 300 $\mu\text{s}$ , Duty cycle < 2.0%.

3. The diode connected between the gate and source serves only as protection ESD. No gate overvoltage rating is implied.

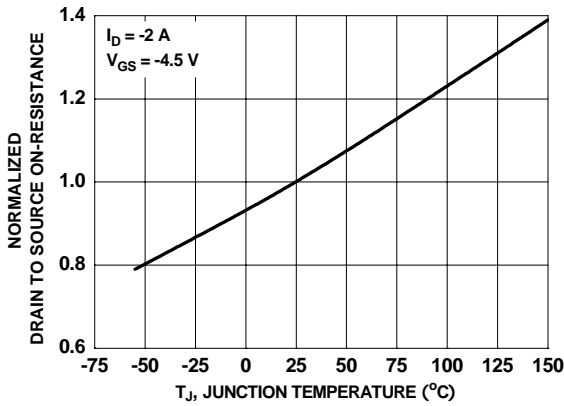
**Typical Characteristics**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted



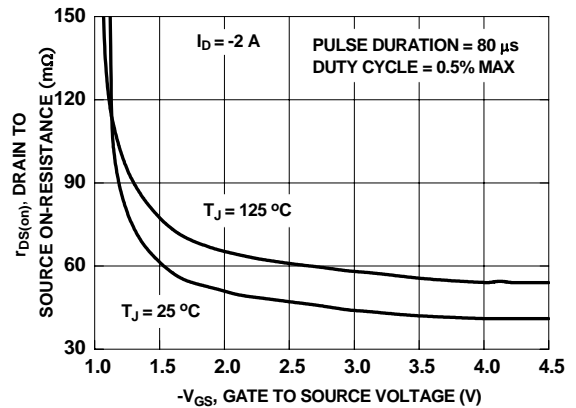
**Figure 1. On-Region Characteristics**



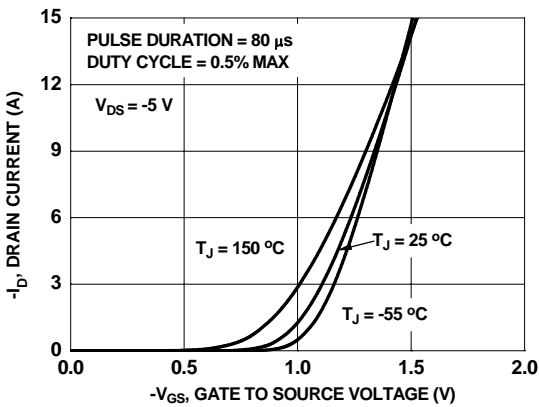
**Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage**



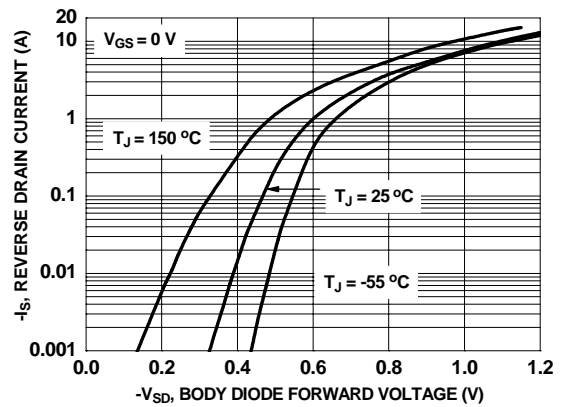
**Figure 3. Normalized On-Resistance vs Junction Temperature**



**Figure 4. On-Resistance vs Gate to Source Voltage**

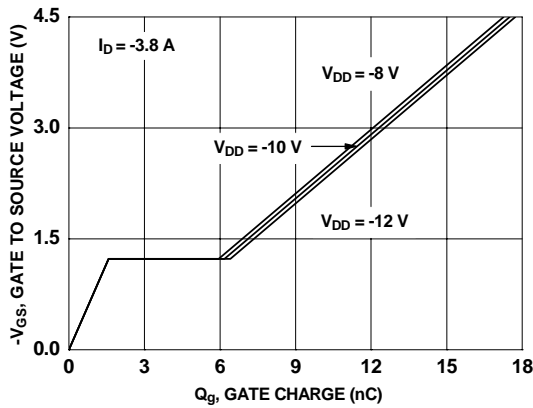


**Figure 5. Transfer Characteristics**

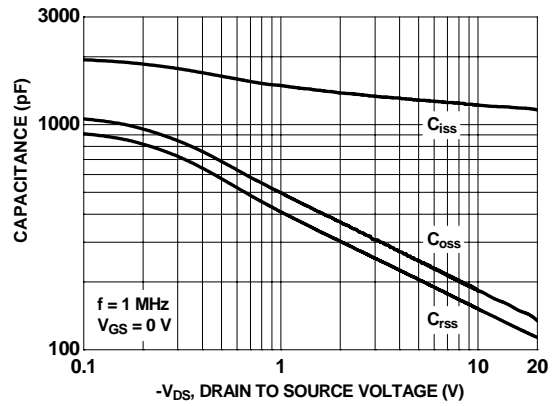


**Figure 6. Source to Drain Diode Forward Voltage vs Source Current**

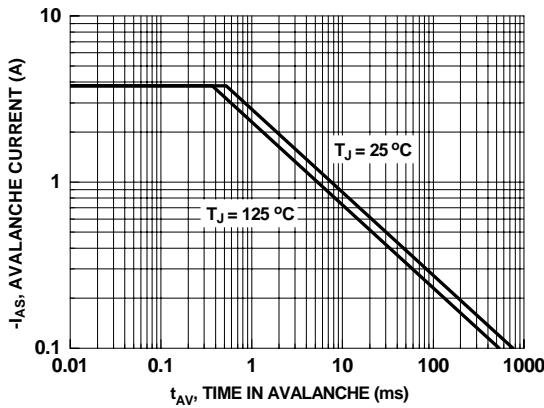
**Typical Characteristics**  $T_J = 25^\circ\text{C}$  unless otherwise noted



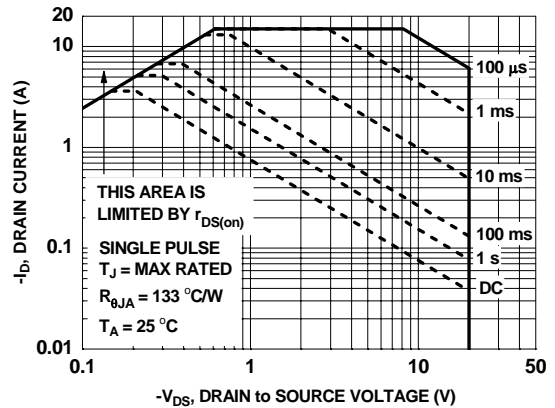
**Figure 7. Gate Charge Characteristics**



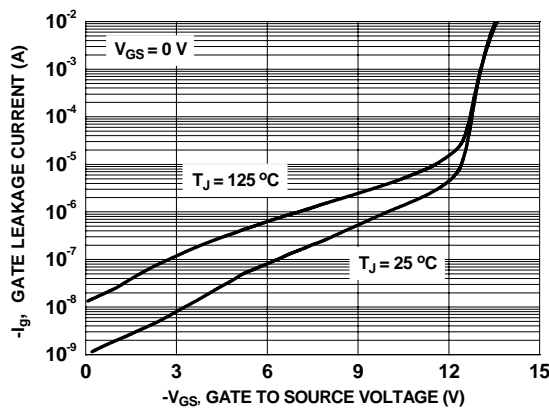
**Figure 8. Capacitance vs Drain to Source Voltage**



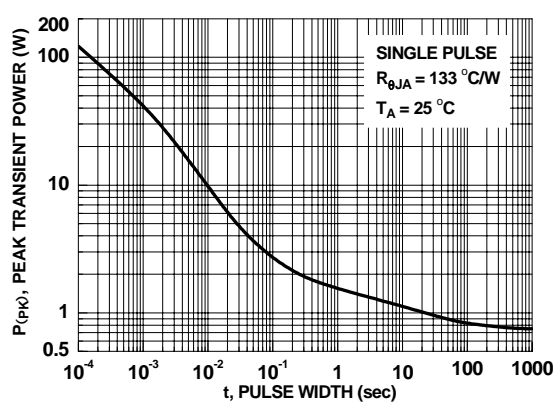
**Figure 9. Unclamped Inductive Switching Capability**



**Figure 10. Forward Bias Safe Operating Area**



**Figure 11. Gate Leakage Current vs Gate to Source Voltage**



**Figure 12. Single Pulse Maximum Power Dissipation**

**Typical Characteristics**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted

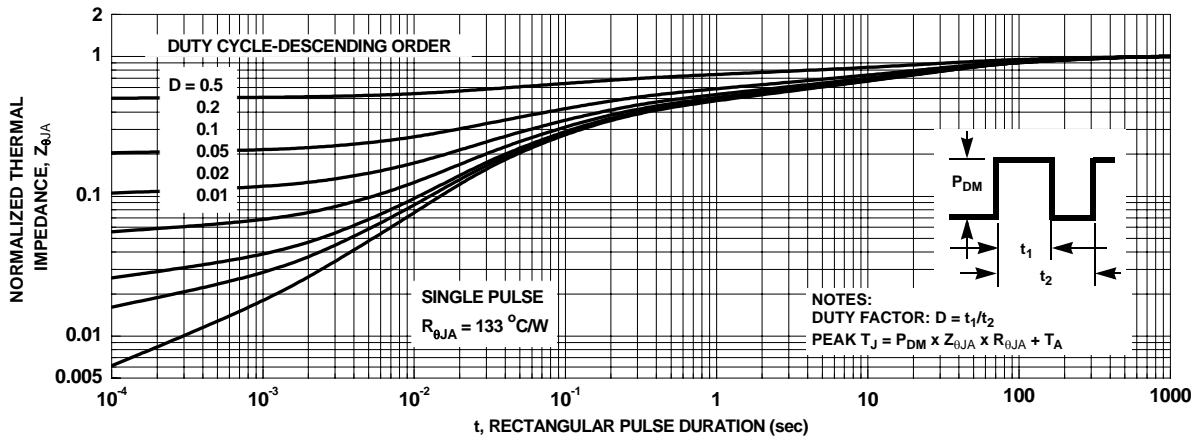
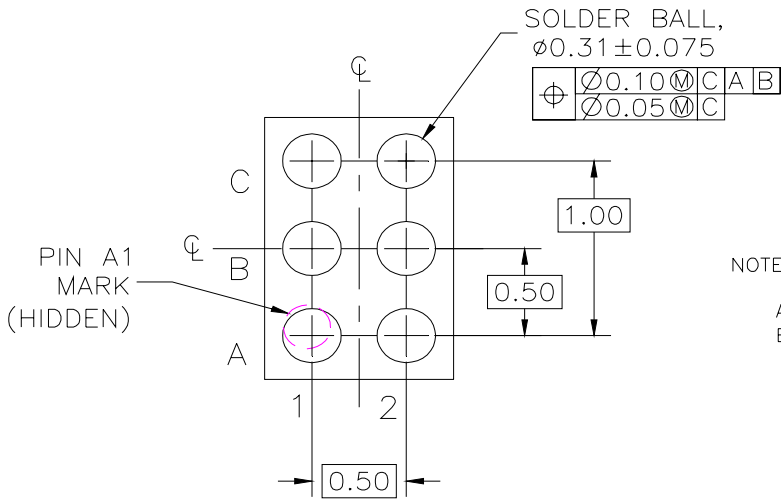
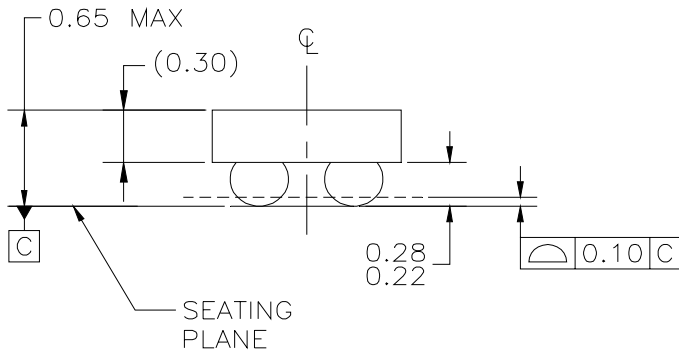
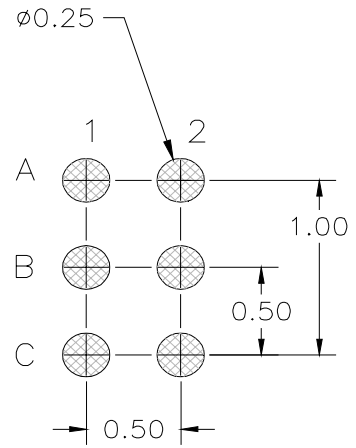
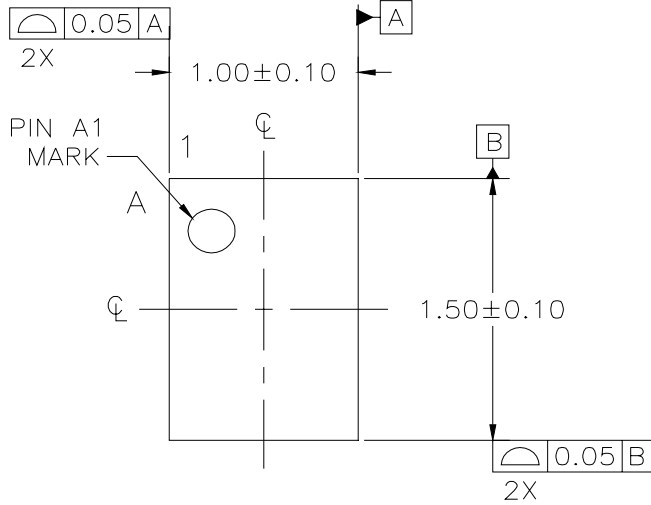


Figure 13. Transient Thermal Response Curve



NOTES: UNLESS OTHERWISE SPECIFIED







- A) ALL DIMENSIONS ARE IN MILLIMETERS.
- B) NO JEDEC REGISTRATION REFERENCE AS OF OCTOBER 2005.

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